Display Elektronik GmbH

DATA SHEET

OLED-MODULE

DEP 128032F-W 2,0" - OLED

Product Specification

Ver.: 0

1. Revision History

VERSION	DATE	REVISED PAGE NO.	Note
0	29.06.2018		First Release

Contents

- 1. Module Classification Information
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1. General Specification

The Features is described as follow:

■ Module Dimension: 59.00 x 18.86 x 1.41 mm

Active Area: 50.535 x 10.695 mm

Dot Matrix: 128 x 32 Dots
Pixel Size: 0.370 x 0.310 mm
Pixel Pitch: 0.395 x 0.335 mm
Display Mode: Passive Matrix

■ Duty: 1/32 Duty

Display Color: White

■ IC: SSD1315

Interface: 8Bits 68xx 80xx/ SPI/ I2C

■ Size: 2.0 Inch

2. Interface Pin Function

No.	Symbol	Function					
1	NC	No connection					
2	VCC	Power supply for panel driving voltage. This is also the most positive power voltage supply pin. When charge pump is enabled, a capacitor should be connected between this pin and VSS.					
3	VCOMH	COM signal deselected voltage level. A capacitor should be connected between this pin and VSS.					
4.	IREF	This is segment output current reference pin. When external IREF is used, a resistor should be connected between this pin and VSS to maintain the IREF current at 30uA.					
5	D7						
6	D6						
7	D5	These are 8-bit bi-directional data bus to be connected to the					
8	D4	microprocessor's data bus. When serial interface mode is selected, D0 will be					
9	D3	ne serial clock input: SCLK; D1 will be the serial data input: SDIN. When I2C mode is selected, D2, D1 should be tied together and serve as SDAout, SDAin in application and D0 is the serial clock input, SCL.					
10	D2						
11	D1	est tout, est and approaction and so to and sometiment, est.					
12	D0						
13	E/RD#	This pin is MCU interface input. When 6800 interface mode is selected, this pin will be used as the Enable (E) signal. Read/write operation is initiated when this pin is pulled HIGH and the chip is selected. When 8080 interface mode is selected, this pin receives the Read (RD#) signal. Read operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS.					
14	R/W#	This is read / write control input pin connecting to the MCU interface. When interfacing to a 6800-series microprocessor, this pin will be used as Read/Write (R/W#) selection input. Read mode will be carried out when this pin is pulled HIGH (i.e. connect to VDD) and write mode when LOW. When 8080 interface mode is selected, this pin will be the Write (WR#) input. Data write operation is initiated when this pin is pulled LOW and the chip is selected. When serial or I2C interface is selected, this pin must be connected to VSS. This pin is Data/Command control pin connecting to the MCU.					
15	D/C#	When the pin is pulled HIGH, the data at D[7:0] will be interpreted as data. When the pin is pulled LOW, the data at D[7:0] will be transferred to a command register.					

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16	RES#	•	•	he pin is pulled LOW, initialization of the (i.e. connect to VDD) during normal
17	CS#		chip select input conne bled for MCU commu	ecting to the MCU. nication only when CS# is pulled LOW
18	NC	No connection		
19	BS2			elect appropriate logic setting as , BS1 and BS0 are pin select
		BS[2:0]	Interface	
		000	4 line SPI	
		001	3 line SPI	
	DO 4	010	I2C	
20	BS1	110	8-bit 8080 parallel	
		100	8-bit 6800 parallel	
		Note (1) 0 is connect (2) 1 is connect		
21	VDD	Power supply p	in for core logic opera	ation. be connected to external source.

22

23

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25

26 27

28 29

30

31

NC

NC

NC

NC

NC

NC NC

NC

VSS

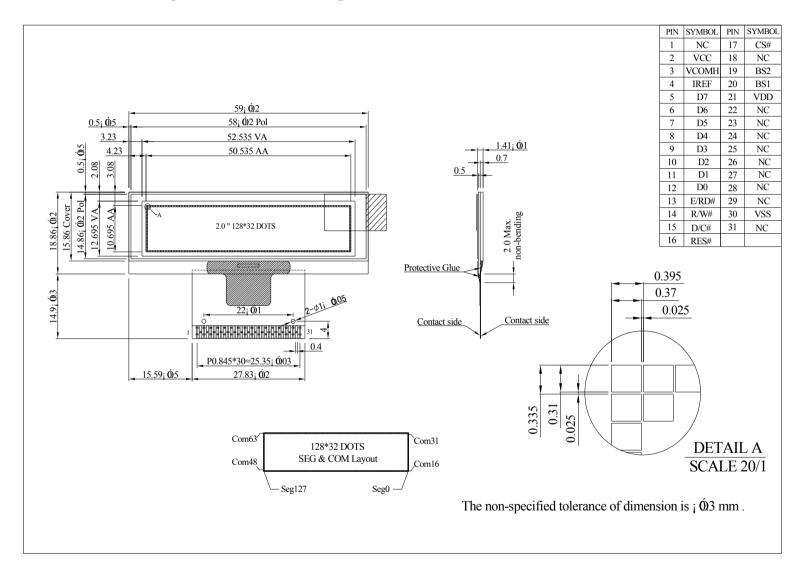
NC

No connection

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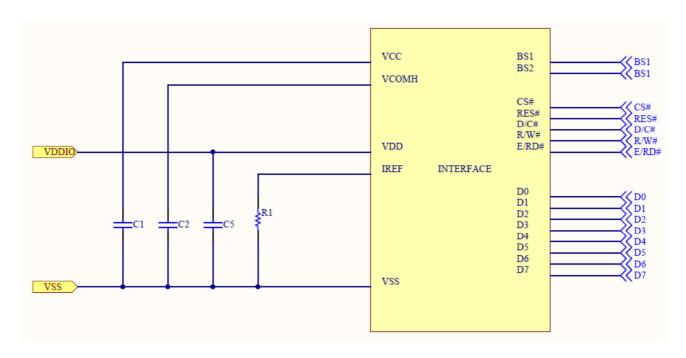
Ground pin. It must be connected to external ground. No connection

3. Counter Drawing & Block Diagram



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3.1 Application Recommendations



Recommended Components:

C5: 1.0uF

C1, C2: 4.7uF

Bus Interface Selection: (Must be set the BS[2:0], refer to item 4)

8-Bits 6800 and 8080 parallel, 3 and 4-Wire SPI, I2C

Voltage at IREF = VCC - 3V. For VCC = 8V, IREF = 30uA: R1 = (Voltage at IREF - VSS) / IREF = (8-3) / $30u \approx 166$ kOhm

*For more information, please contact us.

4. Absolute Maximum Ratings

Unless otherwise specified, VSS= 0V

 $(Ta = 25^{\circ}C)$

Parameter	Symbol	Min	Тур.	Max	Unit	Notes
Supply Voltage for Logic	VDD	-0.3	-	4	V	1,2
Supply Voltage for Display	VCC	0	-	18	V	1,2
Operating Temperature	TOP	-40	-	+80	°C	-
Storage Temperature	TSTG	-40	-	+85	°C	-

Note 1: All the above voltages are on the basis of "VSS = 0V".

Note 2: When this module is used beyond the above absolute maximum ratings, permanent breakage of the module may occur. Also, for normal operations, it is desirable to use this module under the conditions according to Section6 "Electrical Characteristics". If this module is used beyond these conditions, malfunctioning of the module can occur and the reliability of the module may deteriorate.

5. Electrical Characteristics

5.1 DC Electrical Characteristics

Unless otherwise specified, VSS = 0V, VDD = 2.8 - 3.3V (Ta = 25° C)

Items		Symbol	Min.	Тур.	Max.	Unit
Supply	Logic	VDD	2.8	3.0	3.3	V
Voltage	Operating	VCC	7.5	8.0	8.5	V
Input	High Voltage	V _{IH}	0.8 x V _{DD}	-	VDD	V
Voltage	Low Voltage	V_{IL}	0	-	0.2 x VDD	V
Output	High Voltage	V _{OH}	0.9x V _{DD}	-	VDD	V
Voltage	Low Voltage	V_{OL}	0	-	0.1 x VDDIO	V

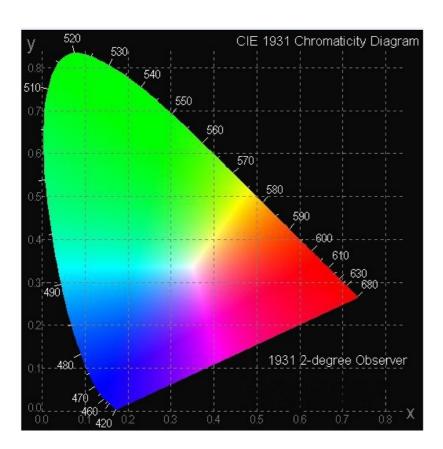
Symbol	Parameter	Min.	Тур.	Max.	Unit	Condition
ICC	VCC Supply Current	ı	11	22	I MA	VDD=3V , VCC=8.0, Display 50% ON

5.2 Initial Code Proposal

```
void init oled()
{
  Write Command(0xAE); // Display Off
  Write_Command(0xD5); //SET DISPLAY CLOCK
  Write Command(0xF0): //105HZ
  Write Command(0xA8); // Select Multiplex Ratio
  Write Command(0x1F);
  Write Command(0xD3); //Setting Display Offset
  Write Command(0x00): //00H Reset
  Write Command(0x40); //Set Display Start Line
  Write Command(0x8D): // Set Charge Pump
  Write Command(0x10); // Endable Charge Pump
  Write Command(0xA1); //Set Segment Re-Map Default
                         //0xA0 (0x00) => column Address 0 mapped to 127
                         //0xA1 (0x01) => Column Address 127 mapped to 0
  Write Command(0xC8); //Set COM Output Scan Direction
                         // 0xC0 (0x00) => normal mode (RESET) Scan from COM0 to
                         COM[N-1]; Where N is the Multiplex ratio.
                         // 0xC8 (0xC8) => remapped mode. Scan from COM[N-1] to
                         COM0::Where N is the Multiplex ratio.
  Write Command(0xDA); //Set COM Hardware Configuration
                         //Alternative COM Pin---See IC Spec page 34
  Write Command(0x12);
                         //(0x02) => A4=0; Sequential COM pin configuration;
                         A5=0:Disable COM Left/Right remap
  Write Command(0x81); //Set Contrast Control
  Write Command(0xFF);
  Write Command(0xD9);
                          //Set Pre-Charge period
  Write Command(0x22);
  Write Command(0xDB); //Set Deselect Vcomh level
  Write Command(0x30);
  Write Command(0xD3); //OFFSET
  Write Command(32):
  Write Command(0xA4): //Entire Display ON
  Write_Command(0xA6); //Set Normal Display
  Write Command(0xAF); // Display ON
}
```

8. Optical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
Viena America	(V)θ	_	160	_	_	deg
View Angle	(Η)φ	_	160	_	_	deg
Contrast Ratio	CR	Dark	2000:1	_	_	_
	T rise	_	_	10	_	μs
Response Time	T fall	_	2000:1 — — — — — — — — — — — — — — — — — — —	μs		
Display with 50%	ghtness	60	80	_	cd/m2	
CIEx(White	(CIE1931)	0.26	0.28	0.30	_	
CIEy(White	e)	(CIE1931)	0.30	0.32	0.34	_



7. OLED Lifetime

ITEM	Conditions	Min	Тур	Remark
Operating Lifetime	Ta=25°C / Initial 50% check board brightness Typical Value	20.000 Hrs	-	Note

Notes:

- 1. Life time is defined the amount of time when the luminance has decayed to <50% of the initial value.
- 2. This analysis method uses life data obtained under accelerated conditions to extrapolate an estimated probability density function (*pdf*) for the product under normal use conditions.
- 3. Screen saving mode will extend OLED lifetime.

8. Reliability

Content of Reliability Test

Environmenta	l Test		
Test Item	Content of Test	Test Condition	Applicable Standard
High Temperature storage	Endurance test applying the high storage temperature for a long time.	+85°C 240hrs	
Low Temperature storage	Endurance test applying the low storage temperature for a long time.	-40°C 240hrs	
High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	+80°C 240hrs	
Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-40°C 240hrs	
High Temperature/ Humidity Storage	Endurance test applying the high temperature and high humidity storage for a long time.	+60°C,90%RH 240hrs	
High Temperature/ Humidity Operation	Endurance test applying the high temperature and high humidity Operation for a long time.	+60°C,90%RH 120hrs	
Temperature Cycle	Endurance test applying the low and high temperature cycle. -40°C +25°C +80°C 30min 5min 30min 1 cycle	-40°C /+80°C 30 cycles	
Mechanical Tes	st		
Vibration test	Endurance test applying the vibration during transportation and using.	Frequency:10~55Hz amplitude:1.5mm Time:0.5hrs/axis Test axis:X,Y,Z	
Others			
Static electricity test	Endurance test applying the electric stress to the terminal.	Air Discharge model ±4kv,10 times	

^{***} Supply voltage for OLED system =Operating voltage at 25°C

Test and measurement conditions

- 1. All measurements shall not be started until the specimens attain to temperature stability. After the completion of the described reliability test, the samples were left at room temperature for 2 hrs prior to conducting the failure test at 23±5°C; 55±15% RH.
- 2. All-pixels-on is used as operation test pattern.
- 3. The degradation of Polarizer are ignored for High Temperature storage, High Temperature/ Humidity Storage, Temperature Cycle

Evaluation criteria

- 1. The function test is OK.
- 2. No observable defects.
- 3. Luminance: > 50% of initial value.
- 4. Current consumption: within ± 50% of initial value.

APPENDIX:

RESIDUE IMAGE

Because the pixels are lighted in different time, the luminance of active pixels may reduce or differ from inactive pixels. Therefore, the residue image will occur. To avoid the residue image, every pixel needs to be lighted up uniformly.

9. Inspection specification

Inspection Standard:

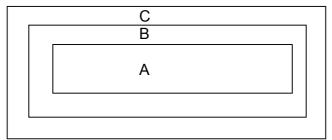
MIL-STD-105E table normal inspection single sample level II.

Definition

1 Major defect : The defect that greatly affect the usability of product.

2 Minor defect: The other defects, such as cosmetic defects, etc.

Definition of inspection zone:



Zone A: Active Area

Zone B: Viewing Area except Zone A

Zone C: Outside Viewing Area

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble of quality and assembly to customer's product.

Inspection Methods

- 1 The general inspection: Under fluorescent light illumination: 750~1500 Lux, about 30cm viewing distance, within 45° viewing angle, under 25°C ± 5°C.
- 2 The luminance and color coordinate inspection: By SR-3 or BM-7 or the equal Equipments in the dark room, under 25°C \pm 5°C.

NO	Item	Criterion	AQL
01	Electrical Testing	 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 OLED viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect. 	0.65
02	Black or white spots on OLED (display only)	 2.1 White and black spots on display ≤0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm. 	2.5

NO	Item			Criterion			AQL
	OLED black spots, white spots, contamin ation (non-display)	3.1 Round ty As following drawing Φ=(x+y)/	2 ((Y	SIZE $\Phi \le 0.10$ $0.10 < \Phi \le 0.20$ $0.20 < \Phi \le 0.25$ $0.25 < \Phi$	Acceptable QTY Accept no dense 2 1 0	Zone A+ B, A+ B A+ B A+ B	2.5
03		3.2 Line type : (As the second		lowing drawing) Width W≤0.02	Acceptable Q TY Accept no	Zone A+B	2.5
			L≦3.0 L≦2.5	0.02 < W ≤ 0.00 0.03 < W ≤ 0.00 0.05 < W	 '	A+B A+B	
04	Polarizer bubbles	If bubbles are visible, judge using black s specifications not easy to fi must check i specify direct	spot 0 s, 0 ind, 1	Size Φ $\Phi \le 0.20$ $0.20 < \Phi \le 0.50$ $0.50 < \Phi \le 1.00$ $0.00 < \Phi$ Total Q TY	Acceptable Q TY Accept no dense 3 2 0 3	Zone A+B A+B A+B A+B	2.5

DEP 128032F-W **Production Specification** NO **AQL** Item Criterion Symbols Define: y: Chip width x: Chip length z: Chip thickness k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length: 6.1 General glass chip: 6.1.1 Chip on panel surface and crack between panels: 2.5 z: Chip thickness y: Chip width x: Chip length $Z \leq 1/2t$ Not over viewing area x≤1/8a $1/2t < z \le 2t$ Not exceed 1/3k x≤1/8a Chipped glass ⊙ If there are 2 or more chips, x is total length of each chip. 6.1.2 Corner crack: 06 2.5 z: Chip thickness y: Chip width x: Chip length Z≦1/2t Not over viewing area x≤1/8a x≤1/8a $1/2t < z \le 2t$ Not exceed 1/3k ⊙ If there are 2 or more chips, x is the total length of each chip. Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length 6.2 Protrusion over terminal: 6.2.1 Chip on electrode pad: Glass 2.5 crack

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x: Chip length

x≤1/8a

z: Chip thickness

 $0\,<\,z\leqq t$

y: Chip width

 $y \leq 0.5 mm$

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Production Specification

NO	Item	Criterion	AQL		
06	Glass crack	6.2.2 Non-conductive portion: Y	2.5		
07	Cracked glass	The OLED with extensive crack is not acceptable.	2.5		
08	Backlight elements	 8.1 Illumination source flickers when lit. 8.2 Spots or scratched that appear when lit must be judged. Using OLED spot, lines and contamination standards. 8.3 Backlight doesn't light or color wrong. 			
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications.	2.5 0.65		

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Production Specification

NO	120032F-W	Criterian Criterian	
NO	Item	Criterion	AQL
10	PCB , COB	10.1 COB seal may not have pinholes larger than 0.2mm or contamination.	2.5
		10.2 COB seal surface may not have pinholes through to the IC.10.3 The height of the COB should not exceed the height indicated in the assembly diagram.	2.5 0.65
		10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than	2.5
		three places. 10.5 No oxidation or contamination PCB terminals. 10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts.	2.5 0.65
		10.7 The jumper on the PCB should conform to the product characteristic chart.	0.65
		10.8 If solder gets on bezel tab pads, OLED pad, zebra pad or screw hold pad, make sure it is smoothed down.	2.5
11	Soldering	11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation	2.5 2.5
		or icicle.	2.5
		11.3 No residue or solder balls on PCB.11.4 No short circuits in components on PCB.	0.65
	General appearance	12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP.	2.5
		12.2 No cracks on interface pin (OLB) of TCP.12.3 No contamination, solder residue or solder balls on product.	0.65 2.5
12		12.4 The IC on the TCP may not be damaged, circuits.12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever.	2.5 2.5
		12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color.	2.5
		12.7 Sealant on top of the ITO circuit has not hardened.	2.5
		12.8 Pin type must match type in specification sheet.	0.65
		12.9 OLED pin loose or missing pins.	0.65
		12.10 Product packaging must the same as specified on packaging specification sheet.	0.65
		12.11 Product dimension and structure must conform to product specification sheet.	0.65

Check Item	Classification	Criteria
No Display	Major	
Missing Line	Major	
Pixel Short	Major	
Darker Short	Major	
Wrong Display	Major	
Un-uniform B/A x 100% < 70% A/C x 100% < 70%	Major	A Normal B Dark Fixel C E Light Fixel

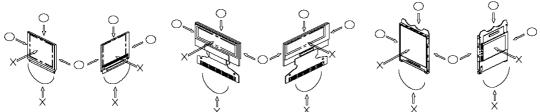
10. Precautions in use of OLED Modules

- (1) Avoid applying excessive shocks to module or making any alterations or modifications to it.
- (2) Don't make extra holes on the printed circuit board, modify its shape or change the components of OLED display module.
- (3) Don't disassemble the OLED display module.
- (4) Don't operate it above the absolute maximum rating.
- (5) Don't drop, bend or twist OLED display module.
- (6) Soldering: only to the I/O terminals.
- (7) Storage: please storage in anti-static electricity container and clean environment.
- (8) It's pretty common to use "Screen Saver" to extend the lifetime and Don't use fix information for long time in real application.
- (9) Don't use fixed information in OLED panel for long time, that will extend "screen burn" effect time.
- (10) DISPLAY has the right to change the passive components, including R2and R3 adjust resistors. (Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.)
- (11) DISPLAY have the right to change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, DISPLAY have the right to modify the version.)

10.1 Handling Precautions

- (1) Since the display panel is being made of glass, do not apply mechanical impacts such us dropping from a high position.
- (2) If the display panel is broken by some accident and the internal organic substance leaks out, be careful not to inhale nor lick the organic substance.
- (3) If pressure is applied to the display surface or its neighborhood of the OLED display module, the cell structure may be damaged and be careful not to apply pressure to these sections
- (4) The polarizer covering the surface of the OLED display module is soft and easily scratched. Please be careful when handling the OLED display module.
- (5) When the surface of the polarizer of the OLED display module has soil, clean the surface. It takes advantage of by using following adhesion tape.
 - * Scotch Mending Tape No. 810 or an equivalent

 Never try to breathe upon the soiled surface nor wipe the surface using cloth containing solvent Also, pay attention that the following liquid and solvent may spoil the polarizer:
 - * Water
 - * Ketone
 - * Aromatic Solvents
- (6) Hold OLED display module very carefully when placing OLED display module into the System housing. Do not apply excessive stress or pressure to OLED display module. And, do not over bend the film with electrode pattern layouts. These stresses will influence the display performance. Also, secure sufficient rigidity for the outer cases.



- (7) Do not apply stress to the LSI chips and the surrounding molded sections.
- (8) Do not disassemble nor modify the OLED display module.
- (9) Do not apply input signals while the logic power is off.
- (10) Pay sufficient attention to the working environments when handing OLED display modules to prevent occurrence of element breakage accidents by static electricity.
 - * Be sure to make human body grounding when handling OLED display modules.
 - * Be sure to ground tools to use or assembly such as soldering irons.
 - * To suppress generation of static electricity, avoid carrying out assembly work under dry environments.
 - * Protective film is being applied to the surface of the display panel of the OLED display module. Be careful since static electricity may be generated when exfoliating the protective film.
- (11) Protection film is being applied to the surface of the display panel and removes the protection film before assembling it. At this time, if the OLED display module has been stored surface of the display panel after removed of the film. In such case, remove the residue material by the method introduced in the above Section 5.
- (12) If electric current is applied when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful to avoid the above.

10.2 Storage Precautions

- (1) When storing OLED display modules, put them in static electricity preventive bags avoiding exposure to direct sun light nor to lights of fluorescent lamps. And, also, avoiding high temperature and high humidity environment or low temperature (less than 0°C) environments. (We recommend you to store these modules in the packaged state when they were shipped from DISPLAY. At that time, be careful not to let water drops adhere to the packages or bags nor let dewing occur with them.
- (2) If electric current is applied when water drops are adhering to the surface of the OLED display module, when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful about the above.

10.3 Designing Precautions

- (1) The absolute maximum ratings are the ratings which cannot be exceeded for OLED display module, and if these values are exceeded, panel damage may be happen.
- (2) To prevent occurrence of malfunctioning by noise, pay attention to satisfy the VIL and VIH specifications and, at the same time, to make the signal line cable as short as possible.
- (3) We recommend you to install excess current preventive unit (fuses, etc.) to the power circuit (VDD). (Recommend value: 0.5A)
- (4) Pay sufficient attention to avoid occurrence of mutual noise interference with the neighboring devices.
- (5) As for EMI, take necessary measures on the equipment side basically.
- (6) When fastening the OLED display module, fasten the external plastic housing section.
- (7) If power supply to the OLED display module is forcibly shut down by such errors as taking out the main battery while the OLED display panel is in operation, we cannot guarantee the quality of this OLED display module. Connection (contact) to any other potential than the above may lead to rupture of the IC.
- (8) The limitation of FPC and Film bending.

